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TABLE OF CONTENTS

CENICS 1: SEMICONDUCTORS AND APPLICATIONS

Novel High Speed and Robust Ultra Low Voltage CMOS NP Domino Carry Gate	1
<i>Abdul Wahab Majeed, Halfdan Solberg Bechmann, Yngvar Berg</i>	
Simultaneous Measurement of Temperature and Expansion on Radio Frequency Power Electronic Components	7
<i>Eric Joubert, Olivier Latry, Jean-Philippe Roux</i>	
Robustness Study of SiC MOSFET Under Harsh Electrical and Thermal Constraints - To an in-depth physical failure analysis	11
<i>Safa Mbarek, Pascal Dherbécourt, Olivier Latry, Francois Fouquet, Dhouha Othman, Mounira Berkani, Stéphane Lefebvre</i>	

CENICS 2: DESIGN AND MICROELECTRONICS

A Log-Tool Suite for Embedded Systems	16
<i>Harald Schuster, Martin Horauer, Michael Kramer, Heinz Liebhart, Josef Buger</i>	
Scan-shift Power Reduction Based on Scan Partitioning and Q-D Connection	21
<i>Tiebin Wu, Li Zhou, Hengzhu Liu</i>	
A Study of Transparent On-chip Instruction Cache for NV Microcontrollers	26
<i>Dahoo Kim, Itaru Hida, Eric S. Fukuda, Tetsuya Asai, Masato Motomura</i>	
Author Index	